

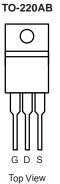
## N-Channel 60 V (D-S) MOSFET

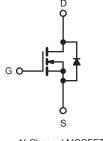
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>				
60	0.024 at V <sub>GS</sub> = 10 V	50				
	0.028 at V <sub>GS</sub> = 4.5 V	40				

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T $_{\rm C}$	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	60	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	V	
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I_	50		
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 100 \text{ °C}$		I <sub>D</sub>	36	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200	1	
Linear Derating Factor			-	1.0	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.025		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		Р	150	w	
Maximum Power Dissipation (PCB Mount) <sup>e</sup>	T <sub>A</sub> =	25 °C	P <sub>D</sub>	3.7	VV	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	T <sub>J</sub> , T <sub>stg</sub> - 55 to + 175		
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for	10 s		300 <sup>d</sup>	- °C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 179 \text{ }\mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

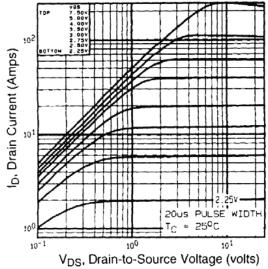
d. 1.6 mm from case.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	ТҮР		MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 62							
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	- 40		°C/W					
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 1.0							
lote . When mounted on 1" square PCB (FR-4	or G-10 material)	. 1							
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, $u$	inless otherwi	ise noted)						-	
PARAMETER	SYMBOL	TES		IONS	MIN.	TYP.	MAX.	UNIT	
Static	-								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 25	50 µA	60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = 2	250 μA	1.0	-	2.5		
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 10	V	-	-	± 100	nA	
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$			-	-	250	μA	
		V <sub>GS</sub> = 10 V		= 21 A <sup>b</sup>	-	0.024	_		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V		= 15 A <sup>b</sup>	_	0.028	-	Ω	
Forward Transconductance	g <sub>fs</sub>	$V_{\rm DS} = 25 \text{ V}, \text{ I}_{\rm D} = 21 \text{ A}^{\rm b}$		23	-	-	S		
Dynamic	313	- 53							
Input Capacitance	C <sub>iss</sub>				-	190			
Output Capacitance	C <sub>oss</sub>		$V_{GS} = 0 V,$			920	_	pF	
Reverse Transfer Capacitance	C <sub>oss</sub> C <sub>rss</sub>	V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5			_	170	_	рг	
•					-	170	66		
Total Gate Charge	Qg	$V_{GS} = 5.0 \text{ V} \qquad \begin{array}{c} I_{D} = 51 \text{ A},  V_{DS} = 48 \text{ V},\\ \text{see fig. 6 and } 13^{\text{b}} \end{array}$			-		nC		
Gate-Source Charge	Q <sub>gs</sub>			-	-	12			
Gate-Drain Charge	Q <sub>gd</sub>				-	-	43		
Turn-On Delay Time	t <sub>d(on)</sub>				-	17	-		
Rise Time	tr	$V_{DD}$ = 30 V, I <sub>D</sub> = 51 A, R <sub>g</sub> = 4.6 $\Omega$ , R <sub>D</sub> = 0.56 $\Omega$ , see fig. 10 <sup>b</sup>			-	230	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	2	-	-		
Fall Time	t <sub>f</sub>			-	110	-			
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L <sub>S</sub>			-	7.5	-			
Drain-Source Body Diode Characteristic	cs								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 <sup>c</sup>	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200			
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 51 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.5	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^{b}$ Intrinsic turn-on time is negligible (turn-or		-	130	180	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC		
Forward Turn-On Time	t <sub>on</sub>			· · ·					

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



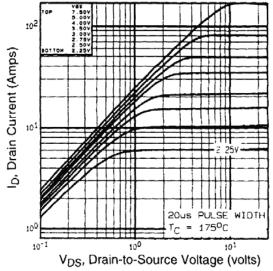
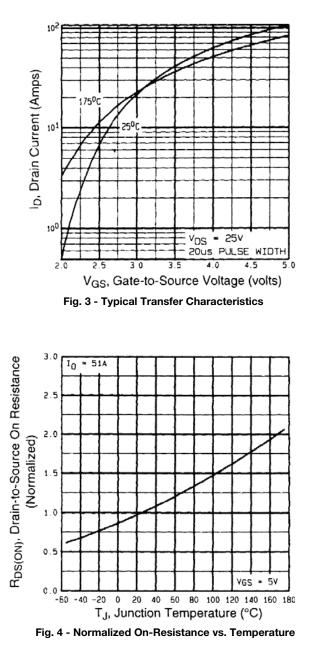


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C





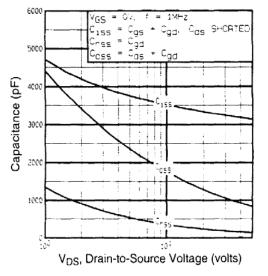


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

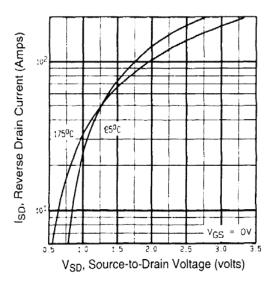
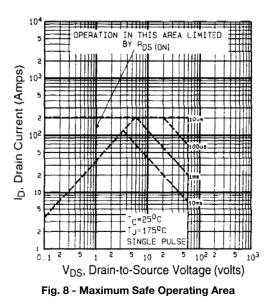


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





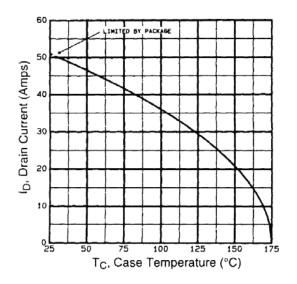


Fig. 9 - Maximum Drain Current vs. Case Temperature

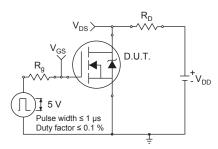


Fig. 10a - Switching Time Test Circuit

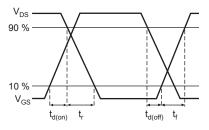


Fig. 10b - Switching Time Waveforms

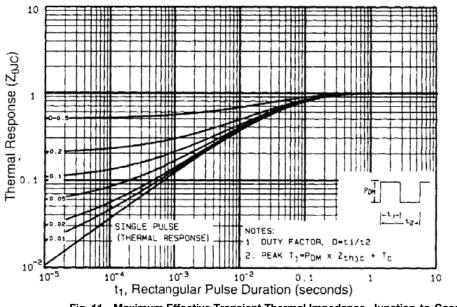


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



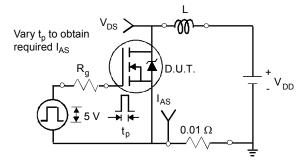


Fig. 12a - Unclamped Inductive Test Circuit

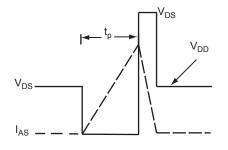


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

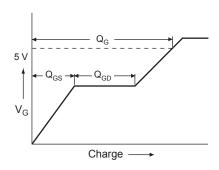


Fig. 13a - Basic Gate Charge Waveform

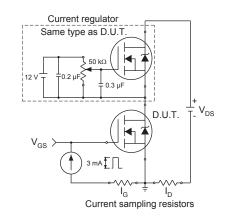
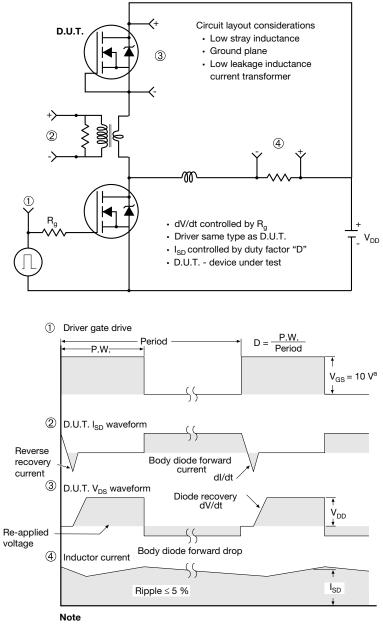


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

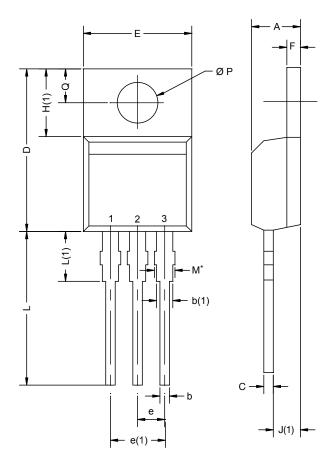


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



## **TO-220AB**



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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